

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/006,123	<b>Applicant(s)/Patent under Reexamination</b> SHIEH ET AL.
	<b>Examiner</b> Joseph Lauture	<b>Art Unit</b> 2819

<b>INTERFERENCE SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
341	144	8/29/2005	JL
341	145	8/29/2005	JL